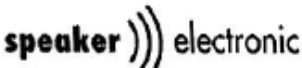




1 Cover Page

RF MPE REPORT

Application No.: SHEM912020125CR
FCC ID: 2AVLY6C
IC: 25810-6C
Applicant: Speaker Electronic (Jiashan) Co., Ltd.
Address of Applicant: No. 8 Development Zone Road, Huimin Sub-district, Jiashan County, Zhejiang, 314112, P.R. China
Manufacturer: Speaker Electronic (Jiashan) Co., Ltd.
Address of Manufacturer: No. 8 Development Zone Road, Huimin Sub-district, Jiashan County, Zhejiang, 314112, P.R. China
Factory: Speaker Electronic (Jiashan) Co., Ltd.
Address of Factory: No. 8 Development Zone Road, Huimin Sub-district, Jiashan County, Zhejiang, 314112, P.R. China
Equipment Under Test (EUT):
EUT Name: Active PA Column System
Model No.: C6
Trade mark: 
Standard(s) : FCC Rules 47 CFR §2.1091
KDB447498 D01 General RF Exposure Guidance v06
RSS-102 Issue 5 (March 2015)
Date of Receipt: 2019-12-27
Date of Test: 2020-03-18 to 2020-04-23
Date of Issue: 2020-04-23

Test Result:	Pass*
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* In the configuration tested, the EUT complied with the standards specified above.

Parlam Zhan

Parlam Zhan
E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



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Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd.
Testing Center E&E (Shanghai)

NO. 588 West Jindu Road, Songjiang District, Shanghai, China 201612
中国·上海·松江区金都西路588号 邮编: 201612

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Revision Record			
Version	Description	Date	Remark
00	Original	2020-04-23	/

Authorized for issue by:			
		Bill Wu	
		Bill Wu / Project Engineer	
		Parlam Zhan	
		Parlam Zhan / Reviewer	



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3 General Information

3.1 General Description of E.U.T.

Power supply:	AC 100-240V~50-60Hz
Cable:	AC Cable 1.7m
Serial Number:	91030001
Firmware Version:	SF-LD MAUI5-630_dv(SE-C6)_20150729

3.2 Technical Specifications

Antenna Gain	1.54dBi
Antenna Type	PCB Antenna
Channel Spacing	1MHz
Modulation Type	GFSK, $\pi/4$ DQPSK, 8DPSK
Number of Channels	79
Operation Frequency	2402MHz to 2480MHz
Spectrum Spread Technology	Frequency Hopping Spread Spectrum(FHSS)



3.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shanghai Branch
588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China
Tel: +86 21 6191 5666 Fax: +86 21 6191 5678

No tests were sub-contracted.

3.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L0599)**

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **NVLAP (LAB CODE: 201034-0)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. is accredited by the National Voluntary Laboratory Accreditation Program (NVLAP).

- **FCC (Designation Number: CN5033)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been recognized as an accredited testing laboratory.

- **ISED (CAB Identifier: CN0020)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. EMC Laboratory has been recognized by Innovation, Science and Economic Development Canada (ISED) as an accredited testing laboratory.

- **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-13868, C-14336, T-12221, G-10830 respectively.

4 Test Standards and Limits

4.1 FCC Radiofrequency radiation exposure limits:

According to §1.1310, the limit for general population/uncontrolled exposures

Frequency	Power density(mW/cm ²)	Averaging time(minutes)
300MHz~1.5GHz	$f/1500$	30
1.5GHz~100GHz	1.0	30

4.2 IC Radiofrequency radiation exposure limits:

According to RSS-102 section 2.5.2, RF exposure evaluation is required if the separation distance between the user and/or bystander and the device's radiating element is greater than 20 cm, except when the device operates as follows:

below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1 W (adjusted for tune-up tolerance);

- at or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $4.49/f^{0.5}$ W (adjusted for tune-up tolerance), where f is in MHz;
- at or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- at or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $1.31 \times 10^{-2} f^{0.6834}$ W (adjusted for tune-up tolerance), where f is in MHz;
- at or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance).

For 2.4G device, the limit of worse case is 2.68 W



5 Measurement and Calculation

5.1 Maximum transmit power

The Power Data is based on the RF Test Report SHEM191202012501

Test Mode	Test Frequency (MHz)	Output Power (dBm)	Reading Power (mW)
GFSK	2402	-1.57	0.70
	2441	2.16	1.64
	2480	2.24	1.67
$\pi/4$ DQPSK	2402	-4.79	0.33
	2441	-0.22	0.95
	2480	0.04	1.01
8DPSK	2402	-4.19	0.38
	2441	0.1	1.02
	2480	0.36	1.09

5.2 MPE Calculation

For FCC:

According to the formula $S=P/4\pi R^2$, we can calculate S which is MPE.

Note:

- 1) P (mW)
- 2) R = distance to the center of radiation of antenna (in meter) = 20cm
- 3) MPE limit = 1mW/cm²

The max. antenna gain is 1.54 dBi

Max. Conducted Power P(mW)	Gain in Linear Scale G	Operation Distance R(cm)	Power Density (mW/cm ²)	Limit (mW/cm ²)	Result
1.67	1.426	20	0.00047	1	Pass

For IC:

$$E.I.R.P.= P \times G = 0.00167W \times 1.426 = 0.0024W < 2.68W$$

So the device is exclusion from SAR test.

--End of the Report--